Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/564,143	TE BAAY ET AL.	
Examiner	Art Unit	

Deborah D. Carr

1621

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
					

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see trancript inventoer name search	9/1/2007	DDC		
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